

4P03L07-VB TO263 Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)	
- 30	0.008 at V_{GS} = - 10 V	- 75	56 nC	
	0.011 at V_{GS} = - 4.5 V	- 65	30 110	

FEATURES

- Halogen-free
- Trench Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested

APPLICATIONS

- Load Switch
- Notebook Adaptor Switch





D P-Channel MOSFET

S O

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 30	V
Gate-Source Voltage		V _{GS}	± 20	
	T _C = 25 °C		- 75	
Continuous Drain Current ($T_1 = 150 \text{ °C}$)	T _C = 70 °C		- 65	
Continuous Drain Current $(T_j = 150^{\circ} C)$	T _A = 25 °C	I _D	-55 ^{a, b}	
	T _A = 70 °C		-45 ^{a, b}	•
Pulsed Drain Current		I _{DM}	- 200	Α
Continuous Courses Davis Diada Current	T _C = 25 °C	1	- 4.1	
Continuous Source-Drain Diode Current	T _A = 25 °C	Is Is	- 2.2 ^{a, b}	
Avalanche Current	L = 0.1 mH	I _{AS}	- 75	
Single-Pulse Avalanche Energy		E _{AS}	280	mJ
	T _C = 25 °C		250	
Maximum Power Dissipation	T _C = 70 °C	Б	205	w
	T _A = 25 °C	P _D	3.7 ^{a, b}	VV
	T _A = 70 °C	1 -	2.7 ^{a, b}	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	38	46	°C/W	
Maximum Junction-to-Foot	Steady State	R _{thJF}	20	25	C/W	

Notes:

b. t = 10 s.

c. Maximum under Steady State conditions is 85 $^{\circ}\text{C/W}.$

d. Based on T_C = 25 °C.

a. Surface mounted on 1" x 1" FR4 board.



SPECIFICATIONS T _J = 25 °C, unless otherwise noted Parameter Symbol Test Conditions Min. Typ. Max. Un								
Static	Symbol	Test conditions	IVIIII.	тур.	IVIAA.	Unit		
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30	[]		V		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	VGS = 0 V; ID = 200 µ/V	- 50	- 34		-		
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		5.3		mV/ °C		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 1.0	5.5	- 2.5	V		
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, \text{ V}_{GS} = \pm 25 \text{ V}$	- 1.0		± 100	· ·		
Gale-Source Leakage	1688	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			- 1	0 nA μA		
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$ $V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 55 \text{ °C}$			- 1			
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -10 \text{ V}, \text{ V}_{GS} = -10 \text{ V}$	- 30			А		
Drain-Source On-State Resistance ^a	_	V _{GS} = - 10 V, I _D = - 10 A		0.008				
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 8 A		0.011		Ω		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		28		S		
Dynamic ^b				11		1		
Input Capacitance	C _{iss}			4550		pF		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		1455				
Reverse Transfer Capacitance	C _{rss}			570				
Total Gate Charge		V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		115				
	Q_g			56				
Gate-Source Charge	Q_{gs} V_{DS} = - 15 V, V_{GS} = - 4.5 V, I_D = - 10 A		8		nC			
Gate-Drain Charge	Q _{gd}			22				
Gate Resistance	R _g	f = 1 MHz	0.5	2.2	4.4	Ω		
Turn-On Delay Time	t _{d(on)}			13	25	ns		
Rise Time	t _r	V_{DD} = - 15 V, R _L = 1.5 Ω		12	24			
Turn-Off DelayTime	t _{d(off)}	${ m I}_{ m D}\cong$ - 10 A, ${ m V}_{ m GEN}$ = - 10 V, ${ m R}_{ m g}$ = 1 Ω		40	70			
Fall Time	t _f	-		9	18			
Turn-On Delay Time	t _{d(on)}			48	80			
Rise Time	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω		92	160			
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		34	60			
Fall Time	t _f			19	35			
Drain-Source Body Diode Characteris	stics							
Continous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 4.1	A		
Pulse Diode Forward Current	I _{SM}				- 60			
Body Diode Voltage	V _{SD}	I _S = - 3 A, V _{GS} = 0 V		- 0.75	- 1.2	V		
Body Diode Reverse Recovery Time	t _{rr}			27	45	ns		
Body Diode Reverse Recovery Charge				16	27	nC		
Reverse Recovery Fall Time	t _a	$I_F = -10 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		12				
Reverse Recovery Rise Time	t _b			15 ns				

Notes:

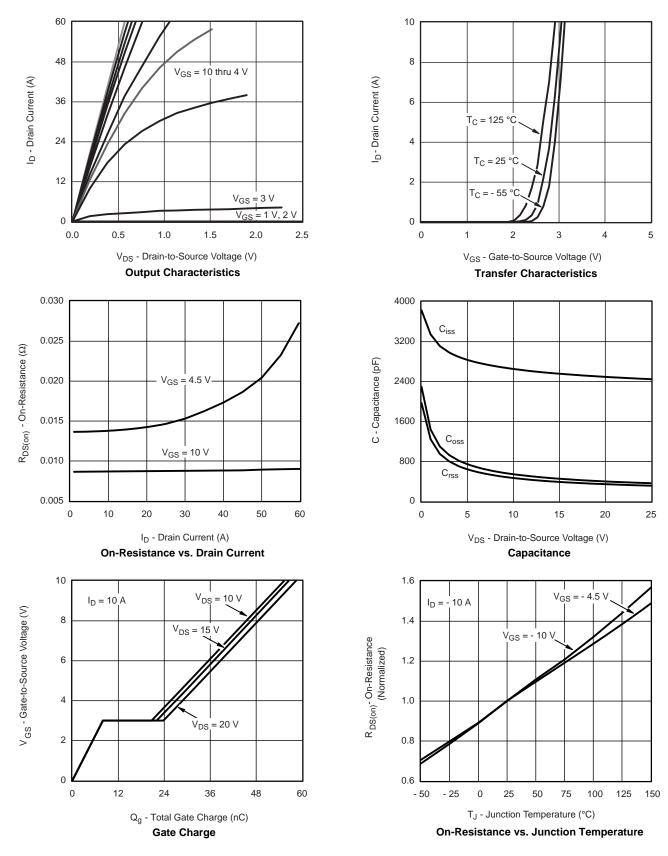
a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

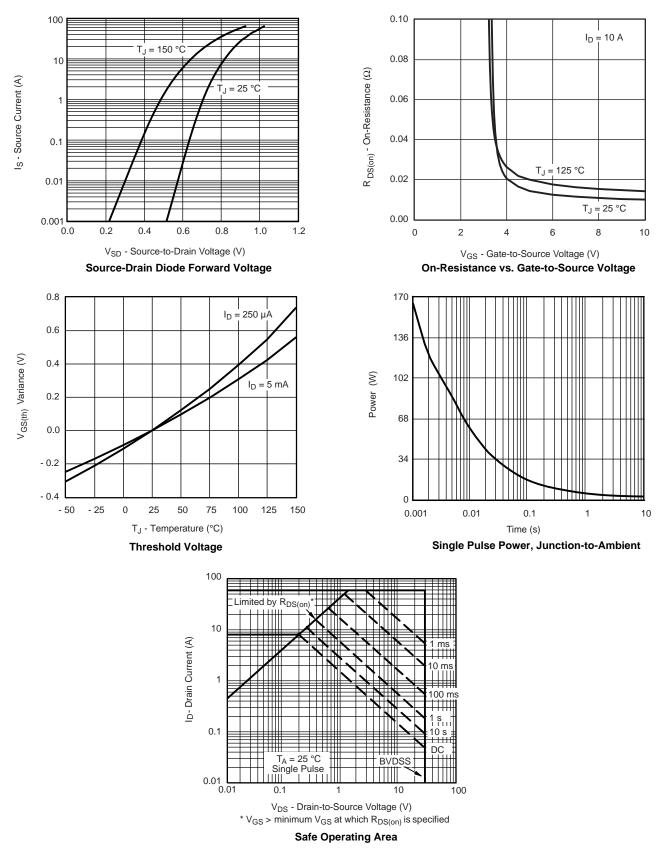






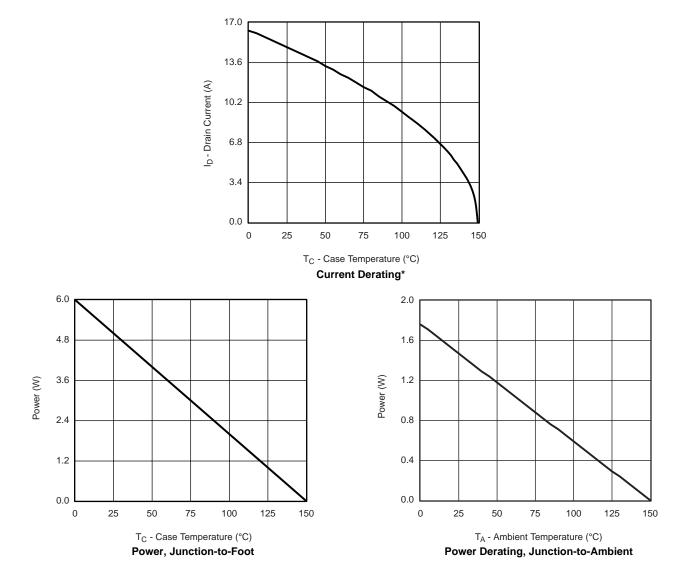








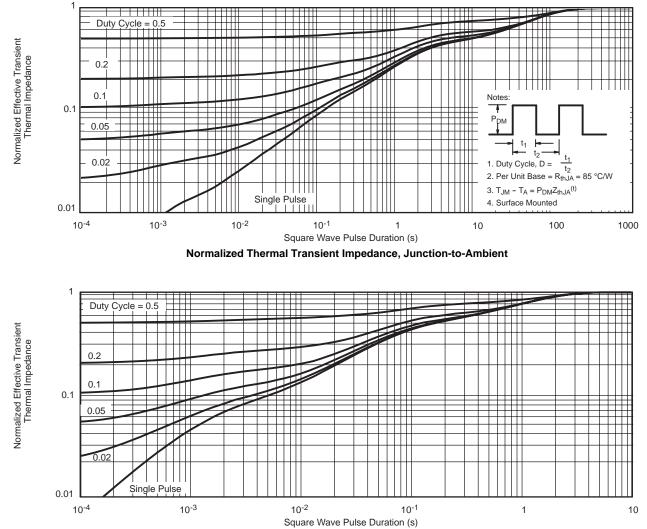
MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



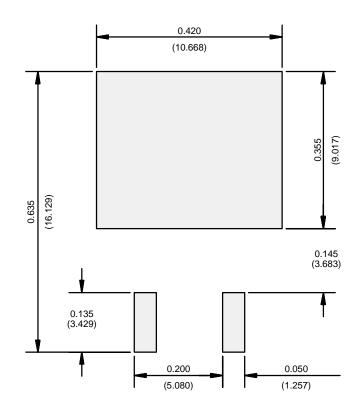
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Foot



RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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